



September 1990

## 54ACQ/74ACQ244 • 54ACTQ/74ACTQ244 Quiet Series Octal Buffer/Line Driver with TRI-STATE® Outputs

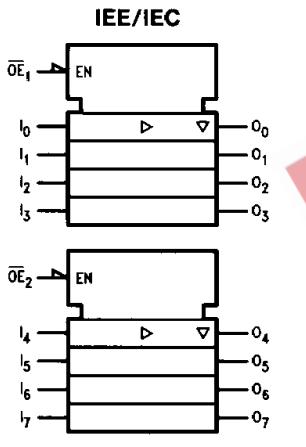
### General Description

The 'ACQ/'ACTQ244 is an octal buffer and line driver designed to be employed as a memory address driver, clock driver and bus oriented transmitter or receiver which provides improved PC board density. The ACQ/ACTQ utilizes NSC Quiet Series technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ features GTOTM output control and undershoot corrector in addition to a split ground bus for superior performance.

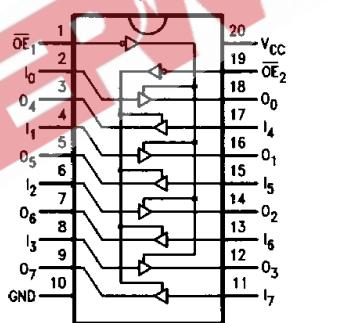
### Features

- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Improved latch-up immunity
- TRI-STATE® outputs drive bus lines or buffer memory address registers
- Outputs source/sink 24 mA
- Faster prop delays than the standard 'AC/'ACT244
- 4 kV minimum ESD immunity
- Standard Military Drawing (SMD)  
—'ACTQ244: 5962-8776003

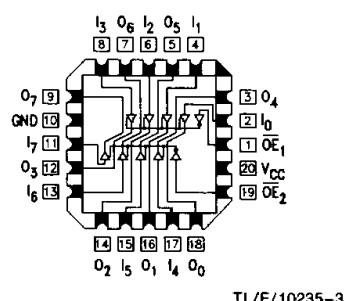
### Logic Symbol



**Pin Assignment  
for DIP, Flatpak and SOIC**



**Pin Assignment  
for LCC and PCC**



### Truth Tables

| Pin Names                          | Description                    |
|------------------------------------|--------------------------------|
| $\overline{OE}_1, \overline{OE}_2$ | TRI-STATE Output Enable Inputs |
| $I_0-I_7$                          | Inputs                         |
| $O_0-O_7$                          | Outputs                        |

| Inputs            |       | Outputs<br>(Pins 12, 14, 16, 18) |
|-------------------|-------|----------------------------------|
| $\overline{OE}_1$ | $I_n$ |                                  |
| L                 | L     | L                                |
| L                 | H     | H                                |
| H                 | X     | Z                                |

| Inputs            |       | Outputs<br>(Pins 3, 5, 7, 9) |
|-------------------|-------|------------------------------|
| $\overline{OE}_2$ | $I_n$ |                              |
| L                 | L     | L                            |
| L                 | H     | H                            |
| H                 | X     | Z                            |

H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Immaterial  
Z = High Impedance

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**54ACQ/74ACQ244 • 54ACTQ/74ACTQ244**  
**Quiet Series Octal Buffer/Line Driver with TRI-STATE Outputs**

## Absolute Maximum Rating (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

|                                                                        |                          |         |
|------------------------------------------------------------------------|--------------------------|---------|
| Supply Voltage ( $V_{CC}$ )                                            | −0.5V to + 7.0V          |         |
| DC Input Diode Current ( $I_{IK}$ )                                    |                          |         |
| $V_I = -0.5V$                                                          | −20 mA                   |         |
| $V_I = V_{CC} + 0.5V$                                                  | +20 mA                   |         |
| DC Input Voltage ( $V_I$ )                                             | −0.5V to $V_{CC} + 0.5V$ |         |
| DC Output Diode Current ( $I_{OK}$ )                                   |                          |         |
| $V_O = -0.5V$                                                          | −20 mA                   |         |
| $V_O = V_{CC} + 0.5V$                                                  | +20 mA                   |         |
| DC Output Voltage ( $V_O$ )                                            | −0.5V to $V_{CC} + 0.5V$ |         |
| DC Output Source or Sink Current ( $I_O$ )                             |                          | ±50 mA  |
| DC $V_{CC}$ or Ground Current per Output Pin ( $I_{CC}$ or $I_{GND}$ ) |                          | ±50 mA  |
| Storage Temperature ( $T_{STG}$ )                                      | −65°C to + 150°C         |         |
| DC Latch-Up Source or Sink Current                                     |                          | ±300 mA |
| Junction Temperature ( $T_J$ )                                         |                          |         |
| CDIP                                                                   | 175°C                    |         |
| PDIP                                                                   | 140°C                    |         |

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT circuits outside databook specifications.

## Recommended Operating Conditions

|                                             |                                      |                  |
|---------------------------------------------|--------------------------------------|------------------|
| Supply Voltage ( $V_{CC}$ )                 | 'ACQ                                 | 2.0V to 6.0V     |
|                                             | 'ACTQ                                | 4.5V to 5.5V     |
| Input Voltage ( $V_I$ )                     |                                      | 0V to $V_{CC}$   |
| Output Voltage ( $V_O$ )                    |                                      | 0V to $V_{CC}$   |
| Operating Temperature ( $T_A$ )             | 74ACQ/ACTQ                           | −40°C to + 85°C  |
|                                             | 54ACQ/ACTQ                           | −55°C to + 125°C |
| Minimum Input Edge Rate $\Delta V/\Delta t$ | 'ACQ Devices                         |                  |
|                                             | $V_{IN}$ from 30% to 70% of $V_{CC}$ |                  |
|                                             | $V_{CC}$ @ 3.0V, 4.5V, 5.5V          | 125 mV/ns        |
| Minimum Input Edge Rate $\Delta V/\Delta t$ | 'ACTQ Devices                        |                  |
|                                             | $V_{IN}$ from 0.8V to 2.0V           |                  |
|                                             | $V_{CC}$ @ 4.5V, 5.5V                | 125 mV/ns        |

## DC Electrical Characteristics for 'ACQ Family Devices

| Symbol    | Parameter                         | $V_{CC}$<br>(V)   | 74ACQ                   |                      | 54ACQ                                   | 74ACQ                                  | Units | Conditions                                                             |
|-----------|-----------------------------------|-------------------|-------------------------|----------------------|-----------------------------------------|----------------------------------------|-------|------------------------------------------------------------------------|
|           |                                   |                   | $T_A = + 25^\circ C$    |                      | $T_A = - 55^\circ C$ to $+ 125^\circ C$ | $T_A = - 40^\circ C$ to $+ 85^\circ C$ |       |                                                                        |
|           |                                   |                   | Typ                     |                      | Guaranteed Limits                       |                                        |       |                                                                        |
| $V_{IH}$  | Minimum High Level Input Voltage  | 3.0<br>4.5<br>5.5 | 1.5<br>2.25<br>2.75     | 2.1<br>3.15<br>3.85  | 2.1<br>3.15<br>3.85                     | 2.1<br>3.15<br>3.85                    | V     | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$                                    |
| $V_{IL}$  | Maximum Low Level Input Voltage   | 3.0<br>4.5<br>5.5 | 1.5<br>2.25<br>2.75     | 0.9<br>1.35<br>1.65  | 0.9<br>1.35<br>1.65                     | 0.9<br>1.35<br>1.65                    | V     | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$                                    |
| $V_{OH}$  | Minimum High Level Output Voltage | 3.0<br>4.5<br>5.5 | 2.99<br>4.49<br>5.49    | 2.9<br>4.4<br>5.4    | 2.9<br>4.4<br>5.4                       | 2.9<br>4.4<br>5.4                      | V     | $I_{OUT} = - 50 \mu A$                                                 |
|           |                                   | 3.0<br>4.5<br>5.5 |                         | 2.56<br>3.86<br>4.86 | 2.4<br>3.7<br>4.7                       | 2.46<br>3.76<br>4.76                   | V     | * $V_{IN} = V_{IL}$ or $V_{IH}$<br>−12 mA<br>−24 mA<br>−24 mA          |
| $V_{OL}$  | Maximum Low Level Output Voltage  | 3.0<br>4.5<br>5.5 | 0.002<br>0.001<br>0.001 | 0.1<br>0.1<br>0.1    | 0.1<br>0.1<br>0.1                       | 0.1<br>0.1<br>0.1                      | V     | $I_{OUT} = 50 \mu A$                                                   |
|           |                                   | 3.0<br>4.5<br>5.5 |                         | 0.36<br>0.36<br>0.36 | 0.50<br>0.50<br>0.50                    | 0.44<br>0.44<br>0.44                   | V     | * $V_{IN} = V_{IL}$ or $V_{IH}$<br>12 mA<br>$I_{OL}$<br>24 mA<br>24 mA |
| $I_{IN}$  | Maximum Input Leakage Current     | 5.5               |                         | ±0.1                 | ±1.0                                    | ±1.0                                   | μA    | $V_I = V_{CC}, GND$ (Note 1)                                           |
| $I_{OLD}$ | †Minimum Dynamic Output Current   | 5.5               |                         |                      | 50                                      | 75                                     | mA    | $V_{OLD} = 1.65V$ Max                                                  |
| $I_{OHD}$ |                                   | 5.5               |                         |                      | −50                                     | −75                                    | mA    | $V_{OHD} = 3.85V$ Min                                                  |
| $I_{CC}$  | Maximum Quiescent Supply Current  | 5.5               |                         | 8.0                  | 160.0                                   | 80.0                                   | μA    | $V_{IN} = V_{CC}$ or GND (Note 1)                                      |

\*All outputs loaded thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

## DC Electrical Characteristics for 'ACQ Family Devices (Continued)

| Symbol           | Parameter                                    | V <sub>CC</sub><br>(V) | 74ACQ                  |                   | 54ACQ                            |  | 74ACQ                           |  | Units | Conditions                                                                                                                                  |  |  |
|------------------|----------------------------------------------|------------------------|------------------------|-------------------|----------------------------------|--|---------------------------------|--|-------|---------------------------------------------------------------------------------------------------------------------------------------------|--|--|
|                  |                                              |                        | T <sub>A</sub> = +25°C |                   | T <sub>A</sub> = -55°C to +125°C |  | T <sub>A</sub> = -40°C to +85°C |  |       |                                                                                                                                             |  |  |
|                  |                                              |                        | Typ                    | Guaranteed Limits |                                  |  |                                 |  |       |                                                                                                                                             |  |  |
| I <sub>OZ</sub>  | Maximum TRI-STATE Leakage Current            | 5.5                    |                        | ±0.5              | ±10.0                            |  | ±5.0                            |  | µA    | V <sub>I</sub> (OE) = V <sub>IL</sub> , V <sub>IH</sub><br>V <sub>I</sub> = V <sub>CC</sub> , GND<br>V <sub>O</sub> = V <sub>CC</sub> , GND |  |  |
| V <sub>OLP</sub> | Quiet Output Maximum Dynamic V <sub>OL</sub> | 5.0                    | 1.1                    | 1.5               |                                  |  |                                 |  | V     | Figures 1, 2<br>(Notes 2, 3)                                                                                                                |  |  |
| V <sub>OLV</sub> | Quiet Output Minimum Dynamic V <sub>OL</sub> | 5.0                    | -0.6                   | -1.2              |                                  |  |                                 |  | V     | Figures 1, 2<br>(Notes 2, 3)                                                                                                                |  |  |
| V <sub>IHD</sub> | Minimum High Level Dynamic Input Voltage     | 5.0                    | 3.1                    | 3.5               |                                  |  |                                 |  | V     | (Notes 2, 4)                                                                                                                                |  |  |
| V <sub>ILD</sub> | Maximum Low Level Dynamic Input Voltage      | 5.0                    | 1.9                    | 1.5               |                                  |  |                                 |  | V     | (Notes 2, 4)                                                                                                                                |  |  |

\*All outputs loaded thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

Note 1: I<sub>IN</sub> and I<sub>CC</sub> @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.

I<sub>CC</sub> for 54ACQ @ 25°C is identical to 74ACQ @ 25°C.

Note 2: Worst case package.

Note 3: Max number of outputs defined as (n). Data Inputs are driven 0V to 5V. One output @ GND.

Note 4: Max number of Data Inputs (n) switching. (n - 1) Inputs switching 0V to 5V ('ACQ). Input-under-test switching: 5V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f = 1 MHz.

## DC Electrical Characteristics for 'ACTQ Family Devices

| Symbol           | Parameter                                    | V <sub>CC</sub><br>(V) | 74ACTQ                 |                   | 54ACTQ                           |  | 74ACTQ                          |  | Units | Conditions                                                                                   |  |  |
|------------------|----------------------------------------------|------------------------|------------------------|-------------------|----------------------------------|--|---------------------------------|--|-------|----------------------------------------------------------------------------------------------|--|--|
|                  |                                              |                        | T <sub>A</sub> = +25°C |                   | T <sub>A</sub> = -55°C to +125°C |  | T <sub>A</sub> = -40°C to +85°C |  |       |                                                                                              |  |  |
|                  |                                              |                        | Typ                    | Guaranteed Limits |                                  |  |                                 |  |       |                                                                                              |  |  |
| V <sub>IH</sub>  | Minimum High Level Input Voltage             | 4.5                    | 1.5                    | 2.0               | 2.0                              |  | 2.0                             |  | V     | V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V                                            |  |  |
|                  |                                              | 5.5                    | 1.5                    | 2.0               | 2.0                              |  | 2.0                             |  |       |                                                                                              |  |  |
| V <sub>IL</sub>  | Maximum Low Level Input Voltage              | 4.5                    | 1.5                    | 0.8               | 0.8                              |  | 0.8                             |  | V     | V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V                                            |  |  |
|                  |                                              | 5.5                    | 1.5                    | 0.8               | 0.8                              |  | 0.8                             |  |       |                                                                                              |  |  |
| V <sub>OH</sub>  | Minimum High Level Output Voltage            | 4.5                    | 4.49                   | 4.4               | 4.4                              |  | 4.4                             |  | V     | I <sub>OUT</sub> = -50 µA                                                                    |  |  |
|                  |                                              | 5.5                    | 5.49                   | 5.4               | 5.4                              |  | 5.4                             |  |       |                                                                                              |  |  |
|                  |                                              | 4.5                    |                        | 3.86              | 3.70                             |  | 3.76                            |  | V     | *V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub><br>I <sub>OH</sub> -24 mA<br>-24 mA    |  |  |
|                  |                                              | 5.5                    |                        | 4.86              | 4.70                             |  | 4.76                            |  |       |                                                                                              |  |  |
| V <sub>OL</sub>  | Maximum Low Level Output Voltage             | 4.5                    | 0.001                  | 0.1               | 0.1                              |  | 0.1                             |  | V     | I <sub>OUT</sub> = 50 µA                                                                     |  |  |
|                  |                                              | 5.5                    | 0.001                  | 0.1               | 0.1                              |  | 0.1                             |  |       |                                                                                              |  |  |
|                  |                                              | 4.5                    |                        | 0.36              | 0.50                             |  | 0.44                            |  | V     | *V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub><br>I <sub>OL</sub> 24 mA<br>24 mA      |  |  |
|                  |                                              | 5.5                    |                        | 0.36              | 0.50                             |  | 0.44                            |  |       |                                                                                              |  |  |
| I <sub>IN</sub>  | Maximum Input Leakage Current                | 5.5                    |                        | ±0.1              | ±1.0                             |  | ±1.0                            |  | µA    | V <sub>I</sub> = V <sub>CC</sub> , GND                                                       |  |  |
| I <sub>OZ</sub>  | Maximum TRI-STATE Leakage Current            | 5.5                    |                        | ±0.5              | ±10.0                            |  | ±5.0                            |  | µA    | V <sub>I</sub> = V <sub>IL</sub> , V <sub>IH</sub><br>V <sub>O</sub> = V <sub>CC</sub> , GND |  |  |
| I <sub>CCT</sub> | Maximum I <sub>CC</sub> /Input               | 5.5                    | 0.6                    |                   | 1.6                              |  | 1.5                             |  | mA    | V <sub>I</sub> = V <sub>CC</sub> - 2.1V                                                      |  |  |
| I <sub>OLD</sub> | †Minimum Dynamic Output Current              | 5.5                    |                        |                   | 50                               |  | 75                              |  | mA    | V <sub>OLD</sub> = 1.65V Max                                                                 |  |  |
|                  |                                              | 5.5                    |                        |                   | -50                              |  | -75                             |  | mA    | V <sub>OHD</sub> = 3.85V Min                                                                 |  |  |
| I <sub>CC</sub>  | Maximum Quiescent Supply Current             | 5.5                    |                        | 8.0               | 160.0                            |  | 80.0                            |  | µA    | V <sub>IN</sub> = V <sub>CC</sub> or GND (Note 1)                                            |  |  |
| V <sub>OLP</sub> | Quiet Output Maximum Dynamic V <sub>OL</sub> | 5.0                    | 1.1                    | 1.5               |                                  |  |                                 |  | V     | Figures 1, 2<br>(Notes 2, 3)                                                                 |  |  |
| V <sub>OLV</sub> | Quiet Output Minimum Dynamic V <sub>OL</sub> | 5.0                    | -0.6                   | -1.2              |                                  |  |                                 |  | V     | Figures 1, 2<br>(Notes 2, 3)                                                                 |  |  |

\*All outputs loaded thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

## DC Electrical Characteristics for 'ACTQ Family Devices (Continued)

| Symbol           | Parameter                                | V <sub>CC</sub><br>(V) | 74ACTQ                 | 54ACTQ                           | 74ACTQ                          | Units | Conditions     |
|------------------|------------------------------------------|------------------------|------------------------|----------------------------------|---------------------------------|-------|----------------|
|                  |                                          |                        | T <sub>A</sub> = +25°C | T <sub>A</sub> = -55°C to +125°C | T <sub>A</sub> = -40°C to +85°C |       |                |
|                  |                                          |                        | Typ                    | Guaranteed Limits                |                                 |       |                |
| V <sub>IHD</sub> | Minimum High Level Dynamic Input Voltage | 5.0                    | 1.9                    | 2.2                              |                                 |       | V (Notes 2, 4) |
| V <sub>ILD</sub> | Maximum Low Level Dynamic Input Voltage  | 5.0                    | 1.2                    | 0.8                              |                                 |       | V (Notes 2, 4) |

\*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

Note 1: I<sub>CC</sub> for 54ACTQ @ 25°C is identical to 74ACTQ @ 25°C.

Note 2: Worst case package.

Note 3: Max number of outputs defined as (n). Data Inputs are driven 0V to 3V. One output @ GND.

Note 4: Max number of Data Inputs (n) switching. (n-1) Inputs switching 0V to 3V ('ACTQ). Input-under-test switching: 3V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f = 1 MHz.

## AC Electrical Characteristics

| Symbol                                | Parameter                              | V <sub>CC</sub> *<br>(V) | 74ACQ                                            |     |      | 54ACQ                                                         |     | 74ACQ                                                        |      | Units |  |
|---------------------------------------|----------------------------------------|--------------------------|--------------------------------------------------|-----|------|---------------------------------------------------------------|-----|--------------------------------------------------------------|------|-------|--|
|                                       |                                        |                          | T <sub>A</sub> = +25°C<br>C <sub>L</sub> = 50 pF |     |      | T <sub>A</sub> = -55°C<br>to +125°C<br>C <sub>L</sub> = 50 pF |     | T <sub>A</sub> = -40°C<br>to +85°C<br>C <sub>L</sub> = 50 pF |      |       |  |
|                                       |                                        |                          | Min                                              | Typ | Max  | Min                                                           | Max | Min                                                          | Max  |       |  |
| t <sub>PHL</sub> , t <sub>PLH</sub>   | Propagation Delay Data to Output       | 3.3                      | 2.0                                              | 7.0 | 9.0  |                                                               |     | 2.0                                                          | 9.5  |       |  |
|                                       |                                        | 5.0                      | 1.5                                              | 5.0 | 6.0  |                                                               |     | 1.5                                                          | 6.5  | ns    |  |
| t <sub>PZL</sub> , t <sub>PZH</sub>   | Output Enable Time                     | 3.3                      | 2.5                                              | 8.0 | 12.0 |                                                               |     | 2.5                                                          | 12.5 |       |  |
|                                       |                                        | 5.0                      | 1.5                                              | 6.5 | 8.0  |                                                               |     | 1.5                                                          | 8.5  | ns    |  |
| t <sub>PHZ</sub> , t <sub>PLZ</sub>   | Output Disable Time                    | 3.3                      | 1.0                                              | 9.0 | 13.5 |                                                               |     | 1.0                                                          | 14.0 |       |  |
|                                       |                                        | 5.0                      | 1.0                                              | 7.5 | 9.0  |                                                               |     | 1.0                                                          | 9.5  | ns    |  |
| t <sub>OSHL</sub> , t <sub>OSLH</sub> | Output to Output Skew** Data to Output | 3.3                      |                                                  | 1.0 | 1.5  |                                                               |     |                                                              | 1.5  |       |  |
|                                       |                                        | 5.0                      |                                                  | 0.5 | 1.0  |                                                               |     |                                                              | 1.0  | ns    |  |

\*Voltage Range 5.0 is 5.0V ± 0.5V.

Voltage Range 3.3 is 3.3V ± 0.3V.

\*\*Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW (t<sub>OSHL</sub>) or LOW to HIGH (t<sub>OSLH</sub>). Parameter guaranteed by design.

## AC Electrical Characteristics

| Symbol                                | Parameter                               | V <sub>CC</sub> *<br>(V) | 74ACTQ                                           |     |     | 54ACTQ                                                        |      | 74ACTQ                                                       |      | Units |  |
|---------------------------------------|-----------------------------------------|--------------------------|--------------------------------------------------|-----|-----|---------------------------------------------------------------|------|--------------------------------------------------------------|------|-------|--|
|                                       |                                         |                          | T <sub>A</sub> = +25°C<br>C <sub>L</sub> = 50 pF |     |     | T <sub>A</sub> = -55°C<br>to +125°C<br>C <sub>L</sub> = 50 pF |      | T <sub>A</sub> = -40°C<br>to +85°C<br>C <sub>L</sub> = 50 pF |      |       |  |
|                                       |                                         |                          | Min                                              | Typ | Max | Min                                                           | Max  | Min                                                          | Max  |       |  |
| t <sub>PHL</sub> , t <sub>PLH</sub>   | Propagation Delay Data to Output        | 5.0                      | 1.5                                              | 5.5 | 6.5 | 1.5                                                           | 9.0  | 1.5                                                          | 7.0  | ns    |  |
| t <sub>PZL</sub> , t <sub>PZH</sub>   | Output Enable Time                      | 5.0                      | 1.5                                              | 7.0 | 8.5 | 1.5                                                           | 10.5 | 1.5                                                          | 9.0  | ns    |  |
| t <sub>PHZ</sub> , t <sub>PLZ</sub>   | Output Disable Time                     | 5.0                      | 1.0                                              | 8.0 | 9.5 | 1.5                                                           | 10.5 | 1.0                                                          | 10.0 | ns    |  |
| t <sub>OSHL</sub> , t <sub>OSLH</sub> | Output to Output Skew ** Data to Output | 5.0                      |                                                  | 0.5 | 1.0 |                                                               |      |                                                              | 1.0  | ns    |  |

\*Voltage Range 5.0 is 5.0V ± 0.5V.

\*\*Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW (t<sub>OSHL</sub>) or LOW to HIGH (t<sub>OSLH</sub>). Parameter guaranteed by design.

## Capacitance

| Symbol   | Parameter                     | Typ | Units | Conditions      |
|----------|-------------------------------|-----|-------|-----------------|
| $C_{IN}$ | Input Capacitance             | 4.5 | pF    | $V_{CC} = 5.0V$ |
| $C_{PD}$ | Power Dissipation Capacitance | 70  | pF    | $V_{CC} = 5.0V$ |

## FACT Noise Characteristics

The setup of a noise characteristics measurement is critical to the accuracy and repeatability of the tests. The following is a brief description of the setup used to measure the noise characteristics of FACT.

### Equipment:

Hewlett Packard Model 8180A Word Generator  
PC-163A Test Fixture  
Tektronics Model 7854 Oscilloscope

### Procedure:

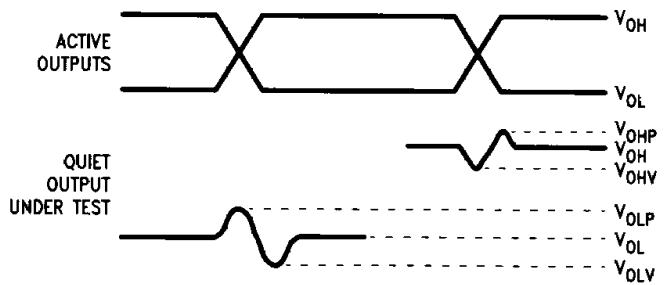
1. Verify Test Fixture Loading: Standard Load 50 pF, 500Ω.
2. Deskew the word generator so that no two channels have greater than 150 ps skew between them. This requires that the oscilloscope be deskewed first. Swap out the channels that have more than 150 ps of skew until all channels being used are within 150 ps. It is important to deskew the word generator channels before testing. This will ensure that the outputs switch simultaneously.
3. Terminate all inputs and outputs to ensure proper loading of the outputs and that the input levels are at the correct voltage.
4. Set  $V_{CC}$  to 5.0V.
5. Set the word generator to toggle all but one output at a frequency of 1 MHz. Greater frequencies will increase DUT heating and affect the results of the measurement.
6. Set the word generator input levels at 0V LOW and 3V HIGH for ACT devices and 0V LOW and 5V HIGH for AC devices. Verify levels with a digital voltmeter.

$V_{OLP}/V_{OLV}$  and  $V_{OHP}/V_{OHV}$ :

- Determine the quiet output pin that demonstrates the greatest noise levels. The worst case pin will usually be the furthest from the ground pin. Monitor the output voltages using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- Measure  $V_{OLP}$  and  $V_{OLV}$  on the quiet output during the HL transition. Measure  $V_{OHP}$  and  $V_{OHV}$  on the quiet output during the LH transition.
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

$V_{ILD}$  and  $V_{IHD}$ :

- Monitor one of the switching outputs using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- First increase the input LOW voltage level,  $V_{IL}$ , until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds  $V_{IL}$  limits, or on output HIGH levels that exceed  $V_{IH}$  limits. The input LOW voltage level at which oscillation occurs is defined as  $V_{ILD}$ .
- Next increase the input HIGH voltage level on the word generator,  $V_{IH}$  until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds  $V_{IL}$  limits, or on output HIGH levels that exceed  $V_{IH}$  limits. The input HIGH voltage level at which oscillation occurs is defined as  $V_{IHD}$ .
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

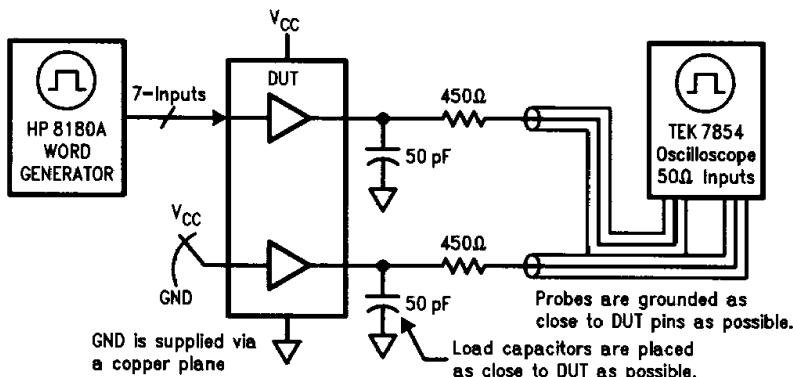


TL/F/10235-4

FIGURE 1. Quiet Output Noise Voltage Waveforms

Note A.  $V_{OHV}$  and  $V_{OLP}$  are measured with respect to ground reference.

Note B. Input pulses have the following characteristics:  $f = 1$  MHz,  $t_r = 3$  ns,  $t_f = 3$  ns, skew < 150 ps.



TL/F/10235-5

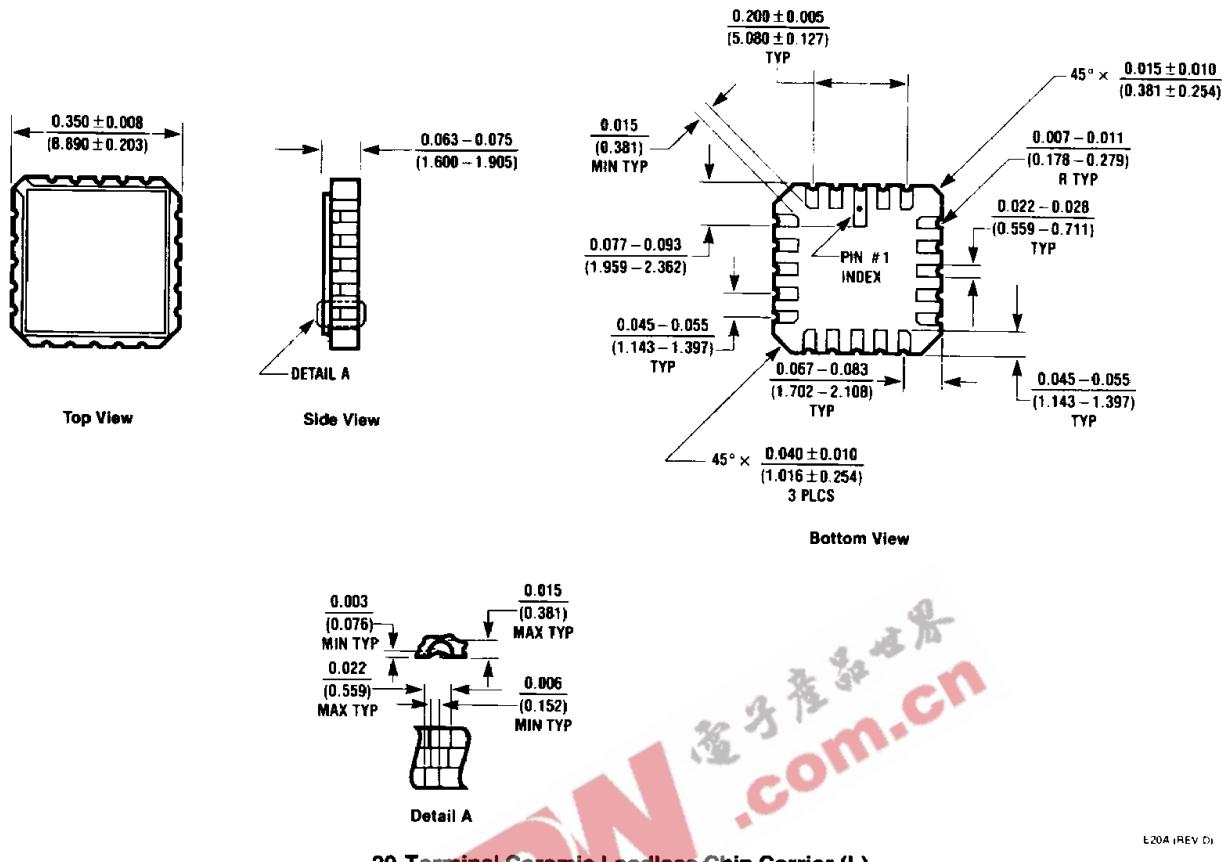
**FIGURE 2. Simultaneous Switching Test Circuit**

## Ordering Information

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:

|                                       |        |     |   |   |    |                                                                                       |
|---------------------------------------|--------|-----|---|---|----|---------------------------------------------------------------------------------------|
| Temperature Range Family              | 74ACTQ | 244 | P | C | QR | Special Variations                                                                    |
|                                       |        |     |   |   |    | X = Devices shipped in 13" reels                                                      |
| 74ACQ = Commercial                    |        |     |   |   |    | QR = Commercial grade device with burn-in                                             |
| 54ACQ = Military                      |        |     |   |   |    | QB = Military grade device with environmental and burn-in processing shipped in tubes |
| 74ACTQ = Commercial TTL-Compatible    |        |     |   |   |    |                                                                                       |
| 54ACTQ = Military TTL-Compatible      |        |     |   |   |    |                                                                                       |
| Device Type                           |        |     |   |   |    | Temperature Range                                                                     |
| Package Code                          |        |     |   |   |    | C = Commercial (-40°C to +85°C)                                                       |
| P = Plastic DIP                       |        |     |   |   |    | M = Military (-55°C to +125°C)                                                        |
| D = Ceramic DIP                       |        |     |   |   |    |                                                                                       |
| F = Flatpak                           |        |     |   |   |    |                                                                                       |
| L = Leadless Chip Carrier (LCC)       |        |     |   |   |    |                                                                                       |
| Q = Plastic Leaded Chip Carrier (PCC) |        |     |   |   |    |                                                                                       |
| S = Small Outline Package (SOIC)      |        |     |   |   |    |                                                                                       |

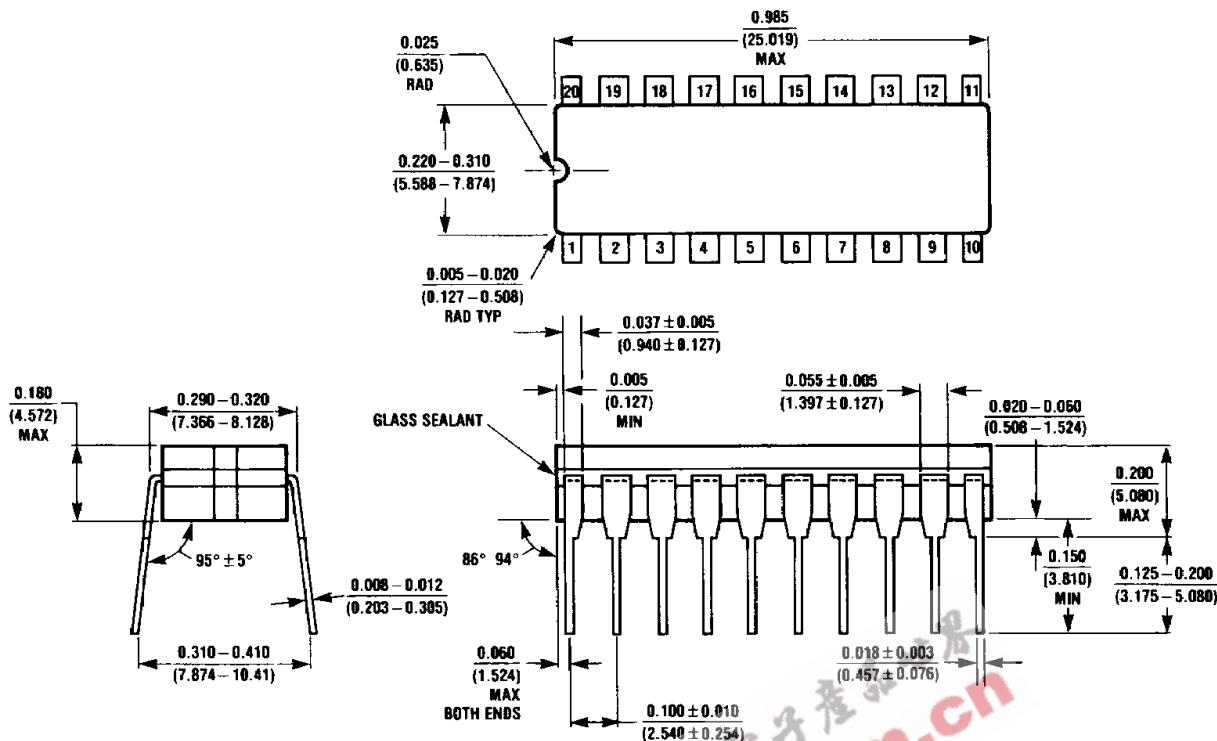
## Physical Dimensions inches (millimeters)



20-Terminal Ceramic Leadless Chip Carrier (L)  
NS Package Number E20A

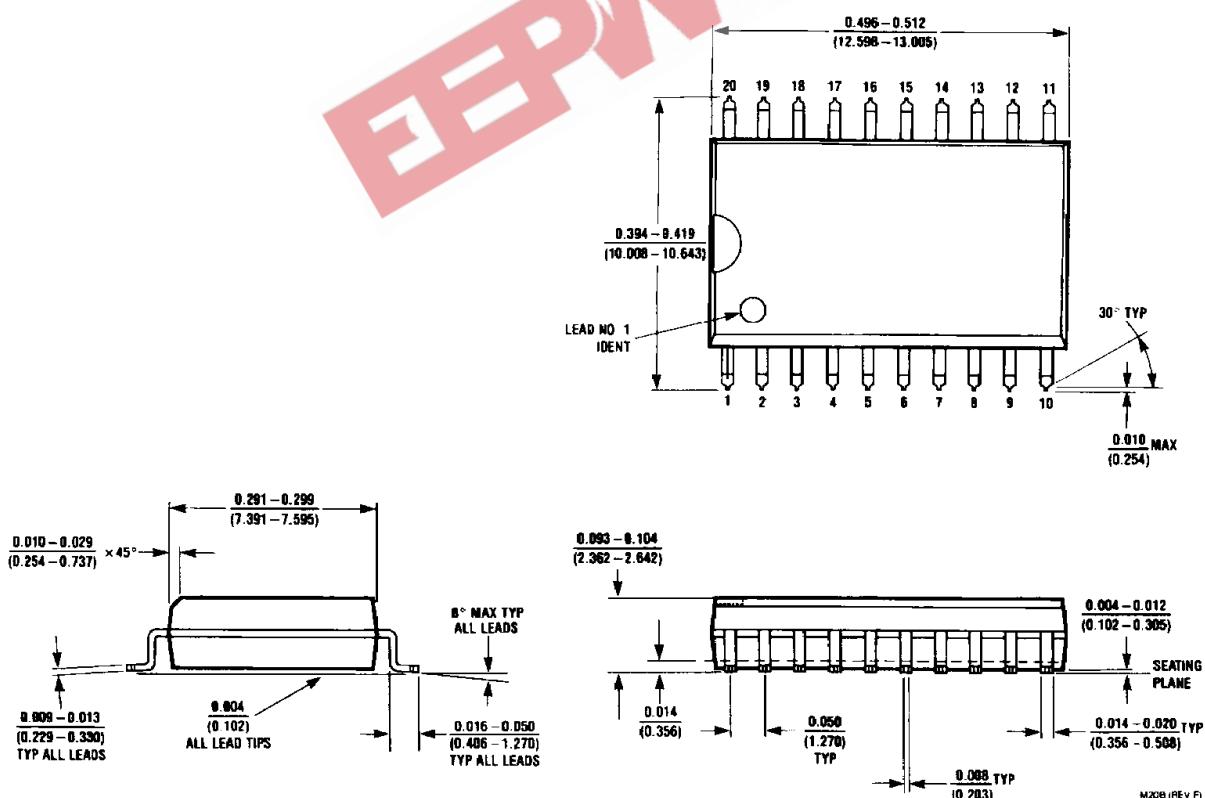
E20A (REV D)

## Physical Dimensions inches (millimeters) (Continued)



J20A (REV M)

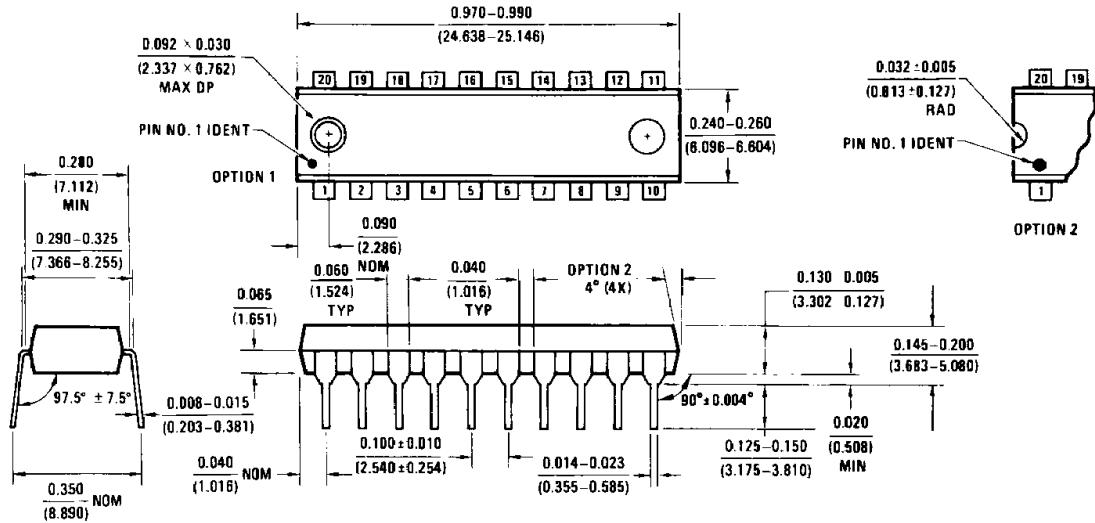
20-Lead Ceramic Dual-In-Line Package (D)  
NS Package Number J20A



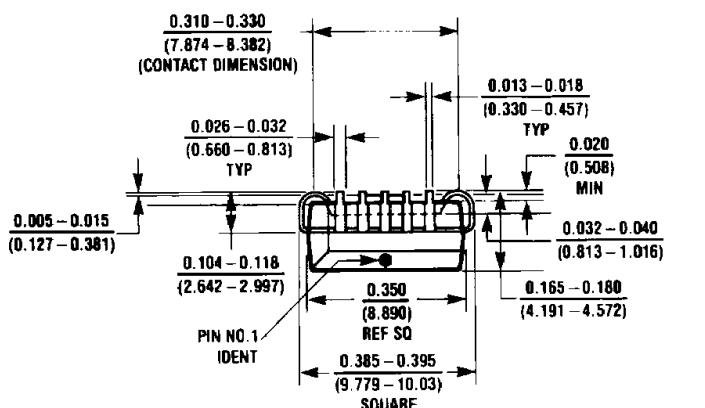
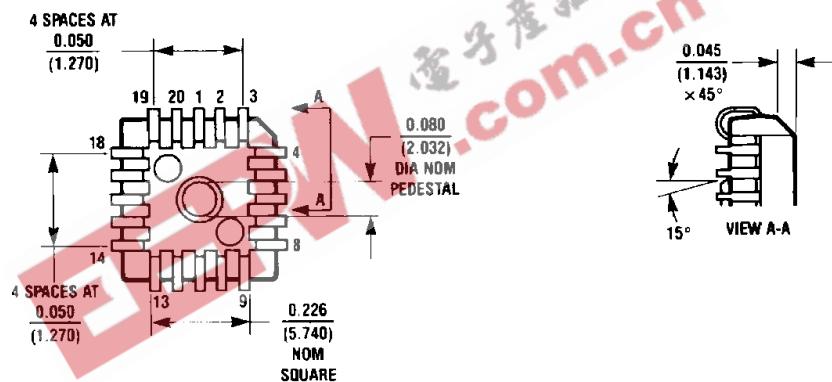
M20B (REV F)

20-Lead Small Outline Integrated Circuit (S)  
NS Package Number M20B

## Physical Dimensions inches (millimeters) (Continued)



20-Lead Plastic Dual-In-Line Package (P)  
NS Package Number N20B

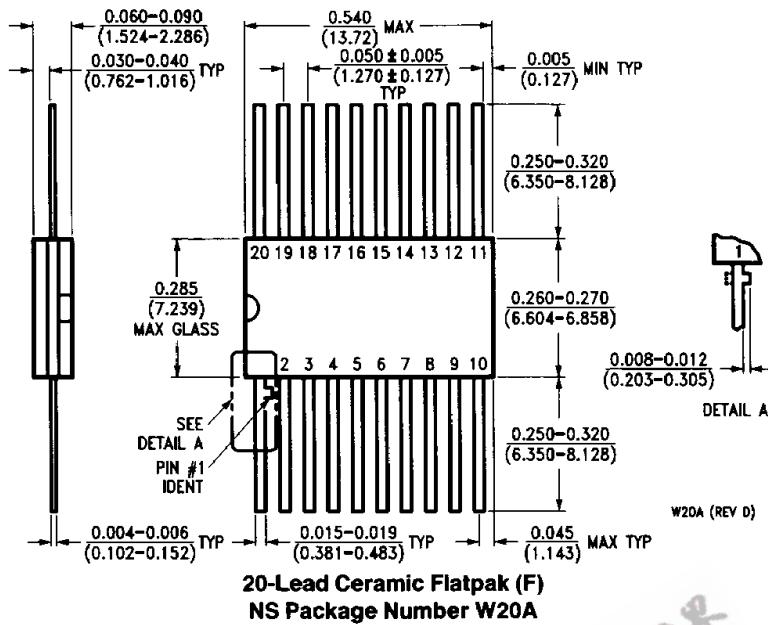


20-Lead Plastic Chip Carrier (Q)  
NS Package Number V20A

V20A (REV J)

## Physical Dimensions inches (millimeters) (Continued)

Lit. # 114674



### LIFE SUPPORT POLICY

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National Semiconductor  
Corporation  
2900 Semiconductor Drive  
P.O. Box 50090  
Santa Clara, CA 95052-8090  
Tel: (1800) 272-9959  
TWX: (910) 339-9240

National Semiconductor  
GmbH  
Industriestrasse 10  
D-8080 Finsenfeldbruck  
West Germany  
Tel: (0-81-41) 103-0  
Telex: 527-649  
Fax: (08141) 103554

National Semiconductor  
Japan Ltd.  
Sansendo Bldg. 5F  
4-15 Nishi Shinjuku  
Shinjuku-Ku,  
Tokyo 160, Japan  
Tel: 3-299-7001  
FAX: 3-299-7000

National Semiconductor  
Hong Kong Ltd.  
Suite 513, 5th Floor  
Chinachem Golden Plaza,  
77 Mody Road, Tsimshatsui East,  
Kowloon, Hong Kong  
Tel: 3-723-1290  
Telex: 52996 NSSEA HX  
Fax: 3-3112536

National Semiconductors  
Do Brasil Ltda.  
Av. Brig. Faria Lima, 1383  
6.0 Andor-Conj. 62  
01451 Sao Paulo, SP, Brasil  
Tel: (55/11) 212-5066  
Fax: (65/11) 211-1181 NSBR BR

National Semiconductor  
(Australia) PTY, Ltd.  
1st Floor, 441 St. Kilda Rd.  
Melbourne, 3004  
Victoria, Australia  
Tel: (03) 267-5000  
Fax: 61-3-2677458